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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/618,602	07/15/2003	Naoki Matsumoto	010986.52602US	5343
	10/618,602 07/15/2003 Naoki Matsumoto	EXAMINER		
			ALEJANDRO MULERO, LUZ L	
			ART UNIT	PAPER NUMBER
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			MAIL DATE	DELIVEDVACOR
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			08/23/2007	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

	Application No.	Applicant(s)			
	10/618,602	MATSUMOTO ET AL.			
Office Action Summary	Examiner	Art Unit			
	Luz L. Alejandro	1763			
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the	he correspondence address			
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DOWN THE MAILING DOWN THE MAILING DOWN THE MAILING DOWN THE MEDICAL STATE OF TH	ATE OF THIS COMMUNICAT 36(a). In no event, however, may a reply will apply and will expire SIX (6) MONTHS, cause the application to become ABAND	TION. be timely filed from the mailing date of this communication. ONED (35 U.S.C. § 133).			
Status		•			
1) Responsive to communication(s) filed on 04 Ju	une 2007.				
2a)⊠ This action is FINAL . 2b)☐ This	This action is FINAL . 2b) This action is non-final.				
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closed in accordance with the practice under E	Ex parte Quayle, 1935 C.D. 11	I, 453 O.G. 213.			
Disposition of Claims					
4) ⊠ Claim(s) <u>1-13 and 15-25</u> is/are pending in the 4a) Of the above claim(s) <u>1-12,18,20 and 24</u> is 5) ☐ Claim(s) is/are allowed. 6) ⊠ Claim(s) <u>13, 15-17,19,21-23 and 25</u> is/are rejection is/are objected to. 8) ☐ Claim(s) are subject to restriction and/or	/are withdrawn from consider	ation.			
Application Papers	·				
9)☐ The specification is objected to by the Examine	er.	•			
10)☐ The drawing(s) filed on is/are: a)☐ acc	epted or b) objected to by	the Examiner.			
Applicant may not request that any objection to the					
Replacement drawing sheet(s) including the correct 11) The oath or declaration is objected to by the Ex					
Priority under 35 U.S.C. § 119	•				
12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of: 1. Certified copies of the priority document 2. Certified copies of the priority document 3. Copies of the certified copies of the priority application from the International Burea * See the attached detailed Office action for a list	ts have been received. ts have been received in Appl crity documents have been rec u (PCT Rule 17.2(a)).	ication No ceived in this National Stage			
Attachment(s) 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO/SB/08) Paper No(s)/Mail Date 0307.	Paper No(s)/M	mary (PTO-413) ail Date mal Patent Application			

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DETAILED ACTION

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

Claims 13, 16, 23, and 25 are rejected under 35 U.S.C. 103(a) as being unpatentable over Taguchi et al., U.S. Patent 6,469,448 in view of Baldwin, Jr. et al., U.S. Patent 6,280,563 and Okabe et al., JP 2000-355771.

Taguchi et al. shows the invention substantially as claimed including a plasma processing apparatus for supplying radio-frequency power into a process chamber so as to generate plasma, to thereby treat an object to be processed with the plasma; wherein the process chamber has a top which is disposed opposite to the object to be processed through the medium of a region for generating the plasma; wherein a

plurality of metal-based radio-frequency antennas 9 are disposed in the process chamber, wherein the process chamber has a chamber wall having at least one antenna so that the antenna penetrates the chamber wall into the inside of the process chamber (see figs. 5 and 12 and their descriptions).

Taguchi et al. does not expressly disclose where the top plate comprises a metal or silicon based material or wherein the antenna provides linear lines so that the direction of electric currents in adjacent antennas are the same, provided that a curved portion may be present in the linear line. Baldwin, Jr. et al. discloses a top plate 44 with a potential applied which is made of a metal (see fig. 1 and its description). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the apparatus of Taguchi et al. so as to have the top plate composed of a metal because, as disclosed by Baldwin, Jr. et al., such a material is suitable for having RF potential applied.

With respect to the antennas, Okabe et al. discloses wherein the antenna provides linear lines (4,5) so that the direction of electric currents in adjacent antennas are the same and the adjacent antennas are in parallel with each other on the same plane which is parallel to the object to be processed (see abstract and Figures). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the apparatus of Taguchi et al. modified by Baldwin, Jr. et al. so as to include the claimed antenna configuration as disclosed by Okabe et al. because using such an antenna arrangement a more uniform plasma over a wider area is possible.

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Concerning claim 16, it would have been obvious to one of ordinary skill in the art at the time the invention was made to determine through routine experimentation the optimum length of the antenna based upon a variety of factors including the desired area of the plasma distribution and such limitation would not lend patentability to the instant application absent a showing of unexpected results.

Regarding claim 23, note that the apparatus as shown in Taguchi et al. includes a susceptor 6 for supporting the object to be processed in the process chamber, and a bias 7 is applicable to the susceptor.

Concerning claim 25, note that in the apparatus of Taguchi et al. modified by Baldwin, Jr. et al. and Tonotani et al. the electric fields are capable of being strengthened by one another.

Claims 15 and 19 are rejected under 35 U.S.C. 103(a) as being unpatentable over Taguchi et al., U.S. Patent 6,469,448 in view of Baldwin, Jr. et al., U.S. Patent 6,280,563 and Okabe et al., JP 2000-355771 as applied to claims 13, 16, 23, and 25 above, and further in view of Glukhoy, US 2003/0168172.

Taguchi et al., Baldwin, Jr. et al., and Okabe et al. are applied as above but do not expressly disclose that the antenna disposed in the process chamber is covered with an insulating material so that the radio-frequency antenna does not directly contact the plasma, and wherein an insulating fluid is circulated between the antenna and the insulating material. Glukhoy discloses that the antenna disposed in the process chamber is covered with an insulating material 64 so that the radio-frequency antenna

does not directly contact the plasma, and wherein an insulating fluid is circulated between the antenna and the insulating material using tubes 82 (see paragraph 0035-0036). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the apparatus of Taguchi et al. modified by Baldwin, Jr. et al. and Okabe et al. in order to cover the antenna with an insulating material and circulate an insulating fluid between the antenna and insulating material because such a structure will protect the antenna as well as control the temperature of the antenna to avoid damage.

Claim 17 is rejected under 35 U.S.C. 103(a) as being unpatentable over Taguchi et al., U.S. Patent 6,469,448 in view of Baldwin, Jr. et al., U.S. Patent 6,280,563 and Okabe et al., JP 2000-355771 as applied to claims 13, 16, 23, and 25 above, and further in view of Holland et al., U.S. Patent 5,975,013 or Takagi et al., US 2004/0020432.

Taguchi et al., Baldwin, Jr. et al., and Okabe et al. are applied as above but do not expressly disclose wherein the thickness or diameter of the radio frequency antenna disposed in the process chamber is changed along with the propagation direction of the radio frequency power. Holland et al. discloses varying the thickness or diameter of a radio frequency antenna (see fig. 11 and its description), as does Takagi et al. (see fig. 2 and its description). In view of these disclosures, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the apparatus of Taguchi et al. modified by Baldwin, Jr. et al. and Okabe et al. so as to vary the thickness

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and/or the diameter of the coil as claimed because in such a way a uniform plasma density can be achieved.

Claims 21-22 are rejected under 35 U.S.C. 103(a) as being unpatentable over Taguchi et al., U.S. Patent 6,469,448 in view of Baldwin, Jr. et al., U.S. Patent 6,280,563 and Okabe et al., JP 2000-355771 as applied to claims 13, 16, 23, and 25 above, and further in view of Grimbergen et al., U.S. Patent 6,390,019.

Taguchi et al., Baldwin, Jr. et al., and Okabe et al. are applied as above but do not expressly disclose wherein a measuring device is disposed in at least one position of the top plate so as to monitor the state of the generated plasma and the top plate has a plurality of apertures for passing a gas to be supplied to the processing chamber. Grimbergen et al. discloses a measuring device 25 which is disposed in the top of the chamber so as to monitor the state of the generated plasma (see fig. 1 and its description), and a top plate which has a plurality of apertures for passing a gas to be supplied to the process chamber (see, for example, figs. 2 and 3a and their descriptions). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the apparatus of Taguchi et al. modified by Baldwin, Jr. et al. and Okabe et al. so as to have the measuring device and apertures as suggested by Grimbergen et al. because having the measuring device and apertures in the top plate allows for accurate measurements and uniform distribution of the gas across the workpiece.

Response to Arguments

Applicant's arguments with respect to claims 13, 15-17, 19, 21-23 and 25 have been considered but are most in view of the new ground(s) of rejection.

Conclusion

Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Luz L. Alejandro whose telephone number is 571-272-1430. The examiner can normally be reached on Monday to Thursday from 7:30 to 6:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Parviz Hassanzadeh can be reached on 571-272-1435. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

Primary Examiner
Art Unit 1763

August 19, 2007